

STARPOWER

SEMICONDUCTOR

IGBT

GD300FFA120C6S

1200V/300A 6 in one-package

General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as general inverters and UPS.

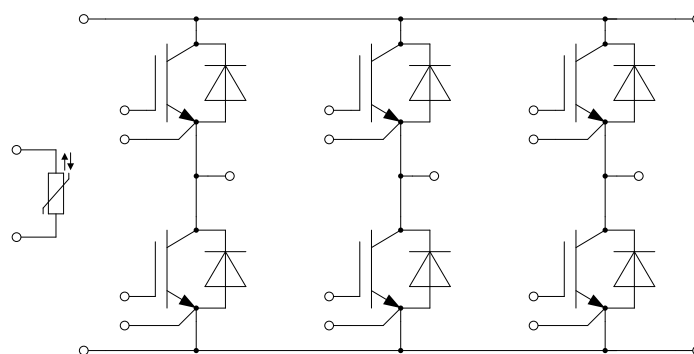
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- 6 μ s short circuit capability
- $V_{CE(sat)}$ with positive temperature coefficient
- Maximum junction temperature 175°C
- Low inductance case
- Fast & soft reverse recovery anti-parallel FWD
- Isolated copper baseplate using DBC technology

Typical Applications

- Inverter for motor drive
- AC and DC servo drive amplifier
- Uninterruptible power supply

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Values	Unit
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$	427	A
	@ $T_C=85^{\circ}\text{C}$	300	
I_{CM}	Pulsed Collector Current $t_p=1\text{ms}$	600	A
P_D	Maximum Power Dissipation @ $T_j=175^{\circ}\text{C}$	1063	W

Diode

Symbol	Description	Values	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1200	V
I_F	Diode Continuous Forward Current	300	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	600	A

Module

Symbol	Description	Values	Unit
T_{jmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{jop}	Operating Junction Temperature	-40 to +150	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	2500	V

IGBT Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=300\text{A}, V_{GE}=15\text{V}, T_j=25^{\circ}\text{C}$		1.40	1.85	V
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_j=125^{\circ}\text{C}$		1.60		
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_j=175^{\circ}\text{C}$		1.60		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=8\text{mA}, V_{CE}=V_{GE}, T_j=25^{\circ}\text{C}$	5.5	6.3	7.0	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$			1.0	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^{\circ}\text{C}$			400	nA
R_{Gint}	Internal Gate Resistance			1.5		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		51.5		nF
C_{res}	Reverse Transfer Capacitance			0.36		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		4.50		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=300\text{A}, R_G=1.5\Omega, L_s=32\text{nH}, V_{GE}=\pm 15\text{V}, T_j=25^{\circ}\text{C}$		405		ns
t_r	Rise Time			83		ns
$t_{d(off)}$	Turn-Off Delay Time			586		ns
t_f	Fall Time			129		ns
E_{on}	Turn-On Switching Loss			34.3		mJ
E_{off}	Turn-Off Switching Loss			19.3		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=300\text{A}, R_G=1.5\Omega, L_s=32\text{nH}, V_{GE}=\pm 15\text{V}, T_j=125^{\circ}\text{C}$		461		ns
t_r	Rise Time			107		ns
$t_{d(off)}$	Turn-Off Delay Time			676		ns
t_f	Fall Time			214		ns
E_{on}	Turn-On Switching Loss			48.0		mJ
E_{off}	Turn-Off Switching Loss			26.6		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=300\text{A}, R_G=1.5\Omega, L_s=32\text{nH}, V_{GE}=\pm 15\text{V}, T_j=175^{\circ}\text{C}$		518		ns
t_r	Rise Time			124		ns
$t_{d(off)}$	Turn-Off Delay Time			738		ns
t_f	Fall Time			264		ns
E_{on}	Turn-On Switching Loss			58.1		mJ
E_{off}	Turn-Off Switching Loss			31.7		mJ
I_{SC}	SC Data	$t_p \leq 7\mu\text{s}, V_{GE}=15\text{V}, T_j=150^{\circ}\text{C}, V_{CC}=800\text{V}, V_{CEM} \leq 1200\text{V}$		1150		A
		$t_p \leq 6\mu\text{s}, V_{GE}=15\text{V}, T_j=175^{\circ}\text{C}, V_{CC}=800\text{V}, V_{CEM} \leq 1200\text{V}$		1110		A

Diode Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_F	Diode Forward Voltage	$I_F=300\text{A}, V_{GE}=0\text{V}, T_J=25^{\circ}\text{C}$		1.60	2.00	V
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_J=125^{\circ}\text{C}$		1.60		
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_J=175^{\circ}\text{C}$		1.50		
Q_r	Recovered Charge	$V_R=600\text{V}, I_F=300\text{A},$ $-di/dt=3135\text{A}/\mu\text{s}, V_{GE}=-15\text{V},$ $L_s=32\text{nH}, T_J=25^{\circ}\text{C}$		19.1		μC
I_{RM}	Peak Reverse Recovery Current			140		A
E_{rec}	Reverse Recovery Energy			4.92		mJ
Q_r	Recovered Charge	$V_R=600\text{V}, I_F=300\text{A},$ $-di/dt=2516\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $L_s=32\text{nH}, T_J=125^{\circ}\text{C}$		33.7		μC
I_{RM}	Peak Reverse Recovery Current			159		A
E_{rec}	Reverse Recovery Energy			9.35		mJ
Q_r	Recovered Charge	$V_R=600\text{V}, I_F=300\text{A},$ $-di/dt=2204\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $L_s=32\text{nH}, T_J=175^{\circ}\text{C}$		46.8		μC
I_{RM}	Peak Reverse Recovery Current			171		A
E_{rec}	Reverse Recovery Energy			13.7		mJ

NTC Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_C=100^{\circ}\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
L_{CE}	Stray Inductance		21		nH
$R_{CC'+EE'}$	Module Lead Resistance, Terminal to Chip		1.80		$\text{m}\Omega$
R_{thJC}	Junction-to-Case (per IGBT)			0.141	K/W
	Junction-to-Case (per Diode)			0.243	
R_{thCH}	Case-to-Heatsink (per IGBT)		0.085		K/W
	Case-to-Heatsink (per Diode)		0.147		
	Case-to-Heatsink (per Module)		0.009		
M	Mounting Screw:M6	3.0		6.0	N.m
G	Weight of Module		300		g

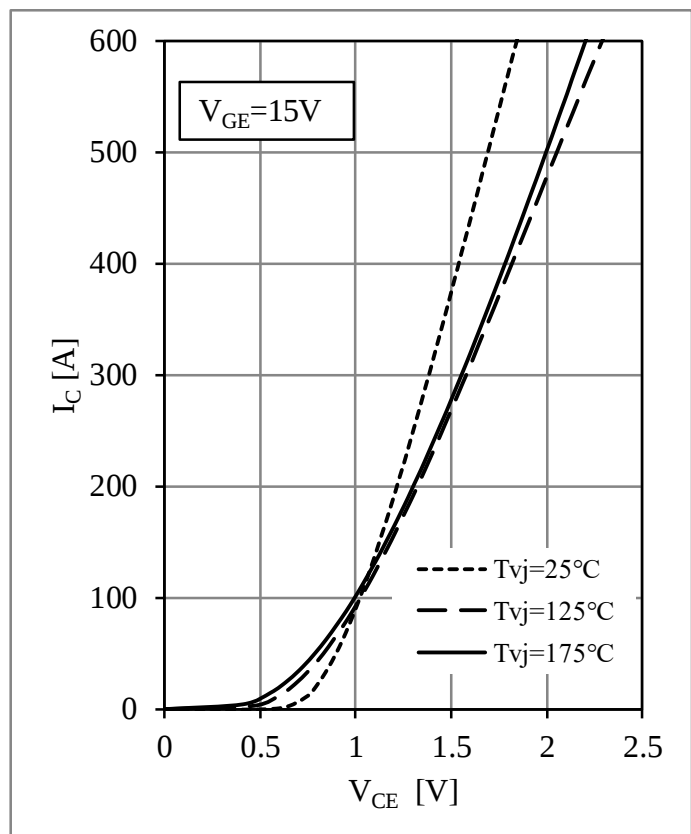


Fig 1. IGBT Output Characteristics

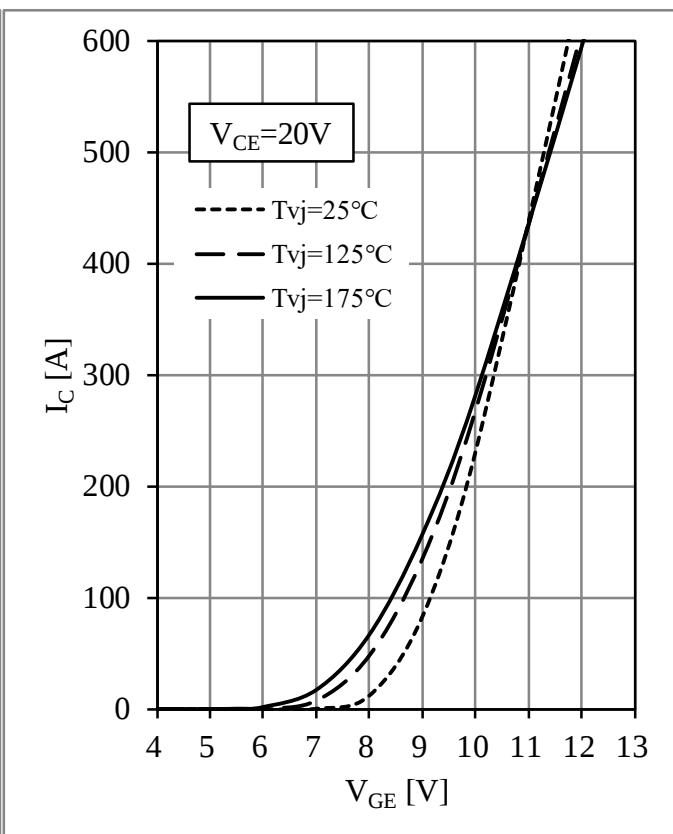
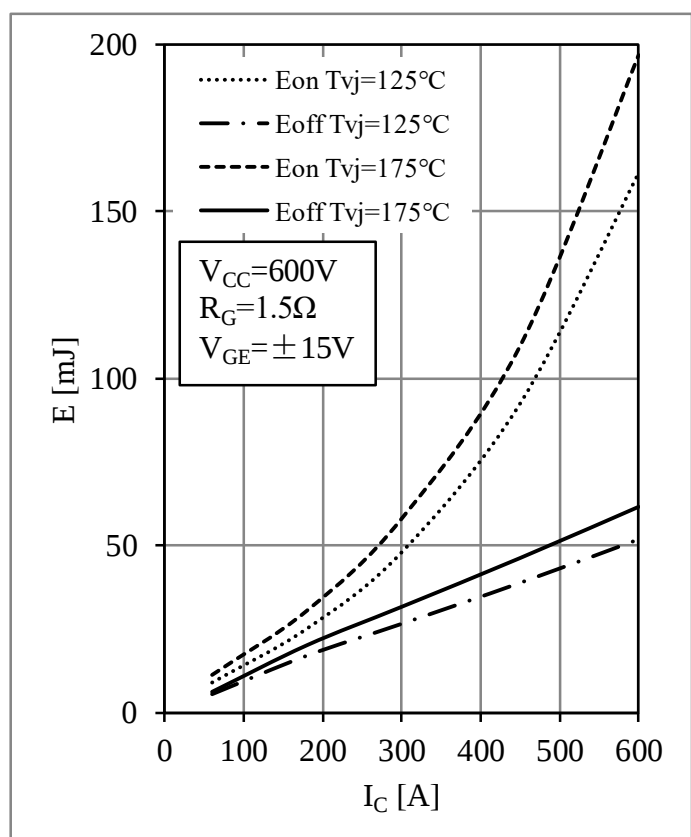
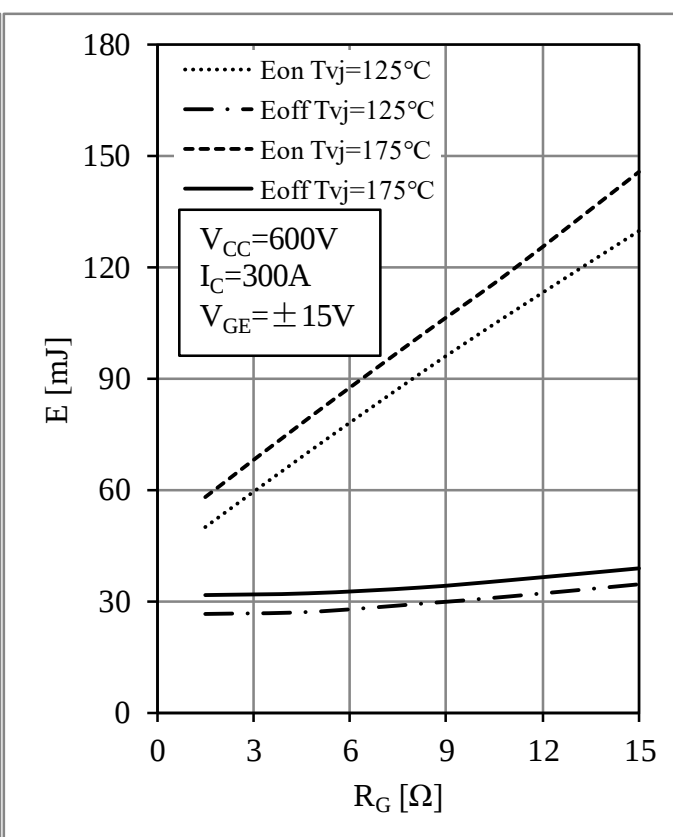


Fig 2. IGBT Transfer Characteristics

Fig 3. IGBT Switching Loss vs. I_C Fig 4. IGBT Switching Loss vs. R_G

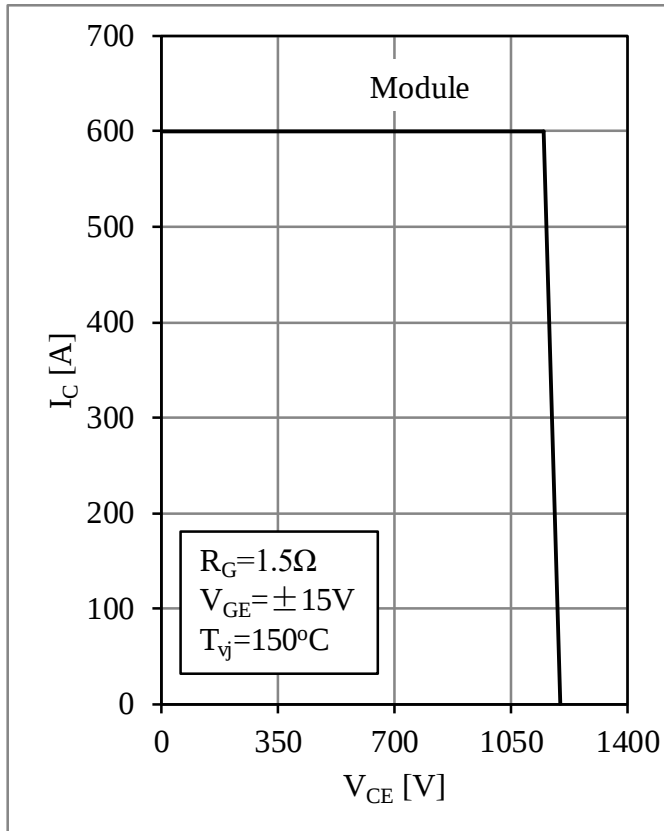


Fig 5. IGBT RBSOA

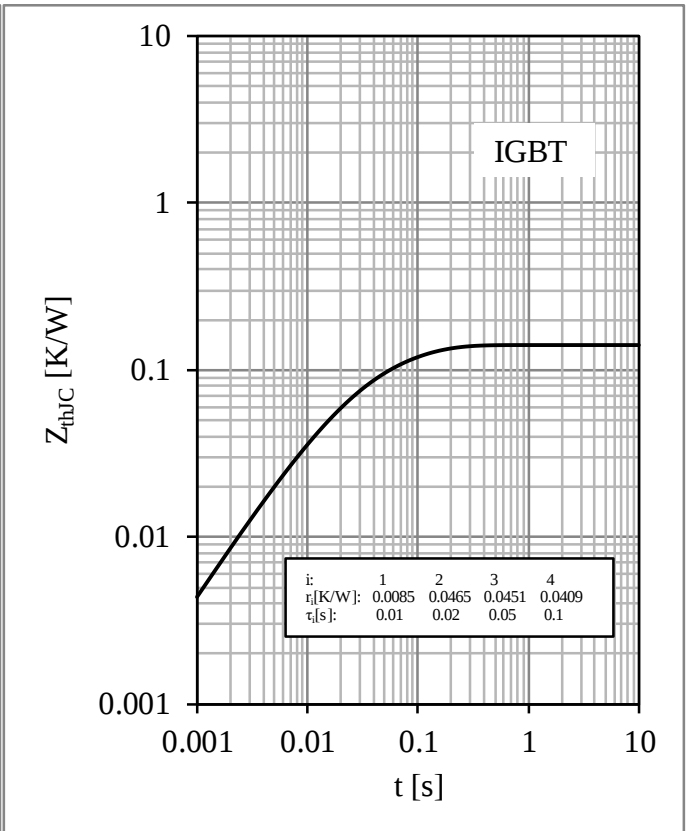


Fig 6. IGBT Transient Thermal Impedance

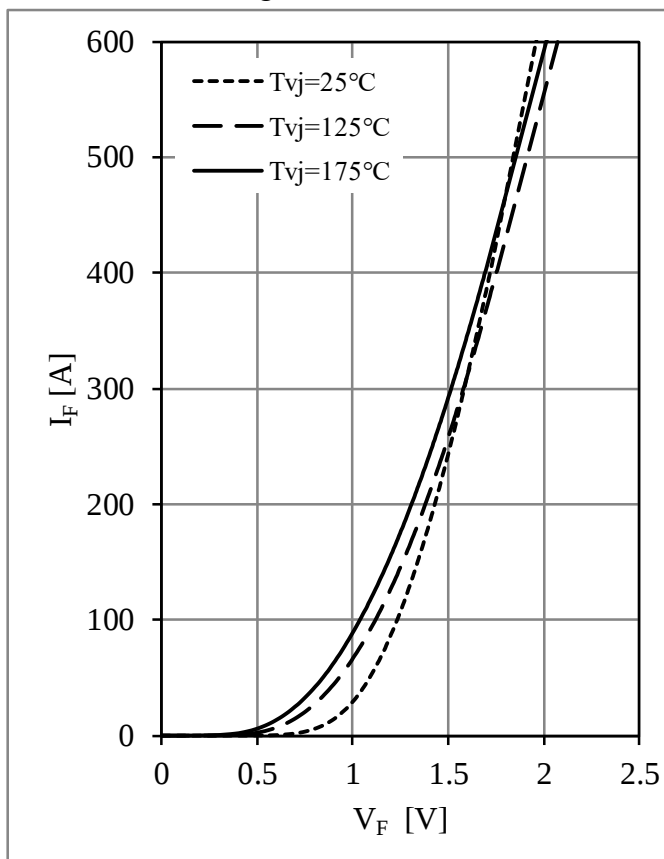
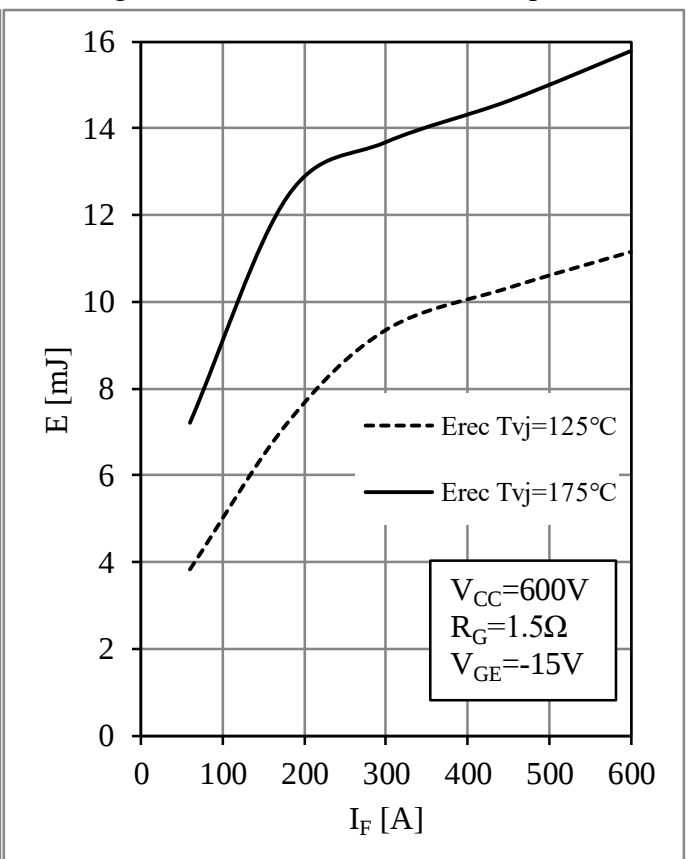
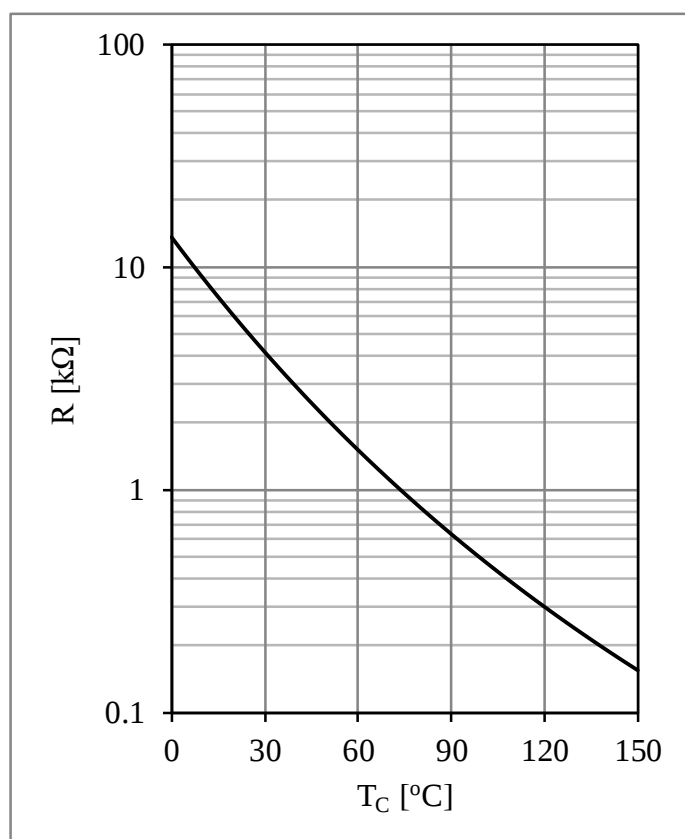
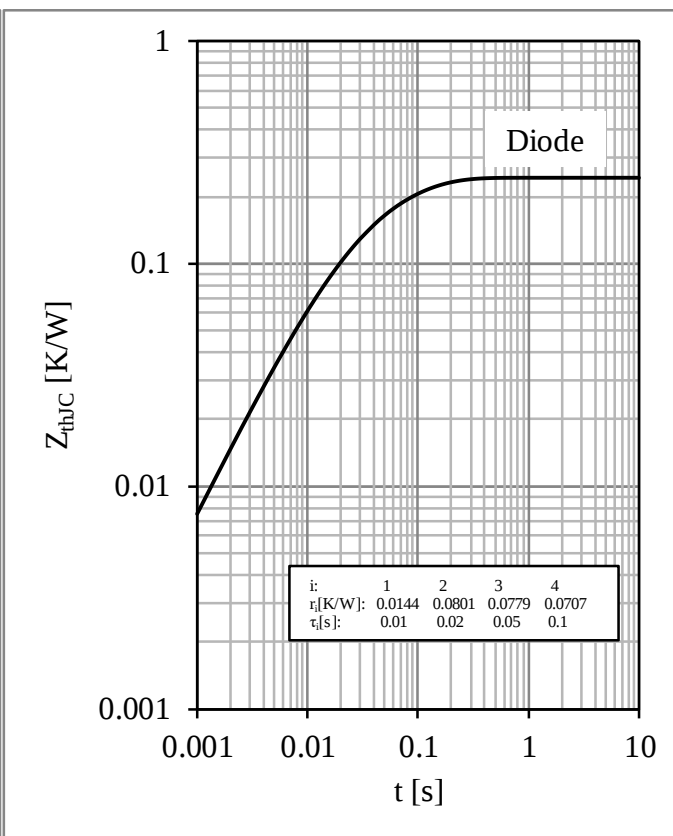
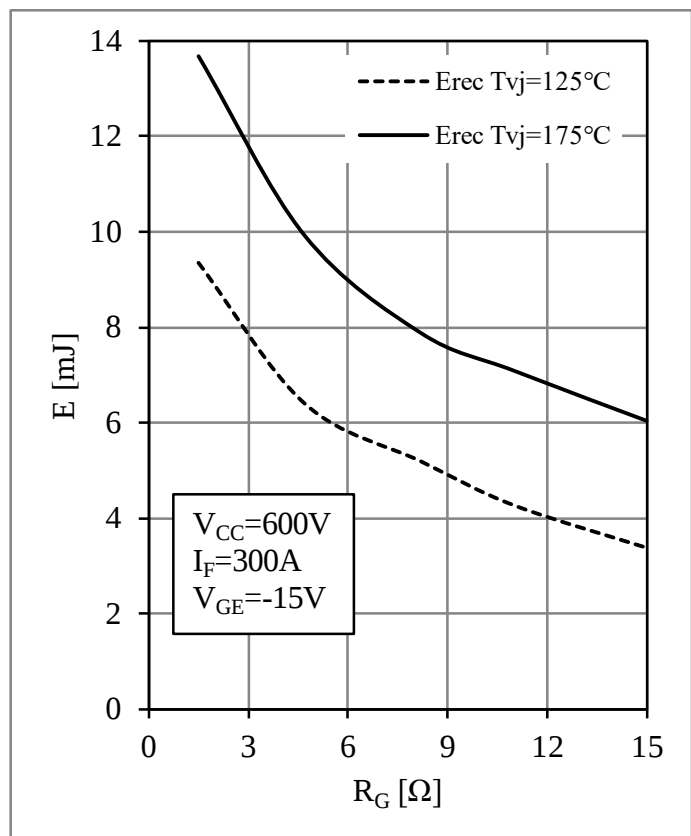
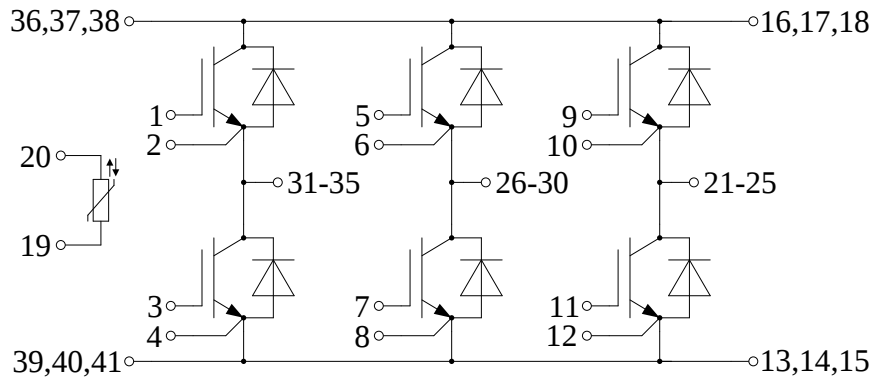


Fig 7. Diode Forward Characteristics

Fig 8. Diode Switching Loss vs. I_F

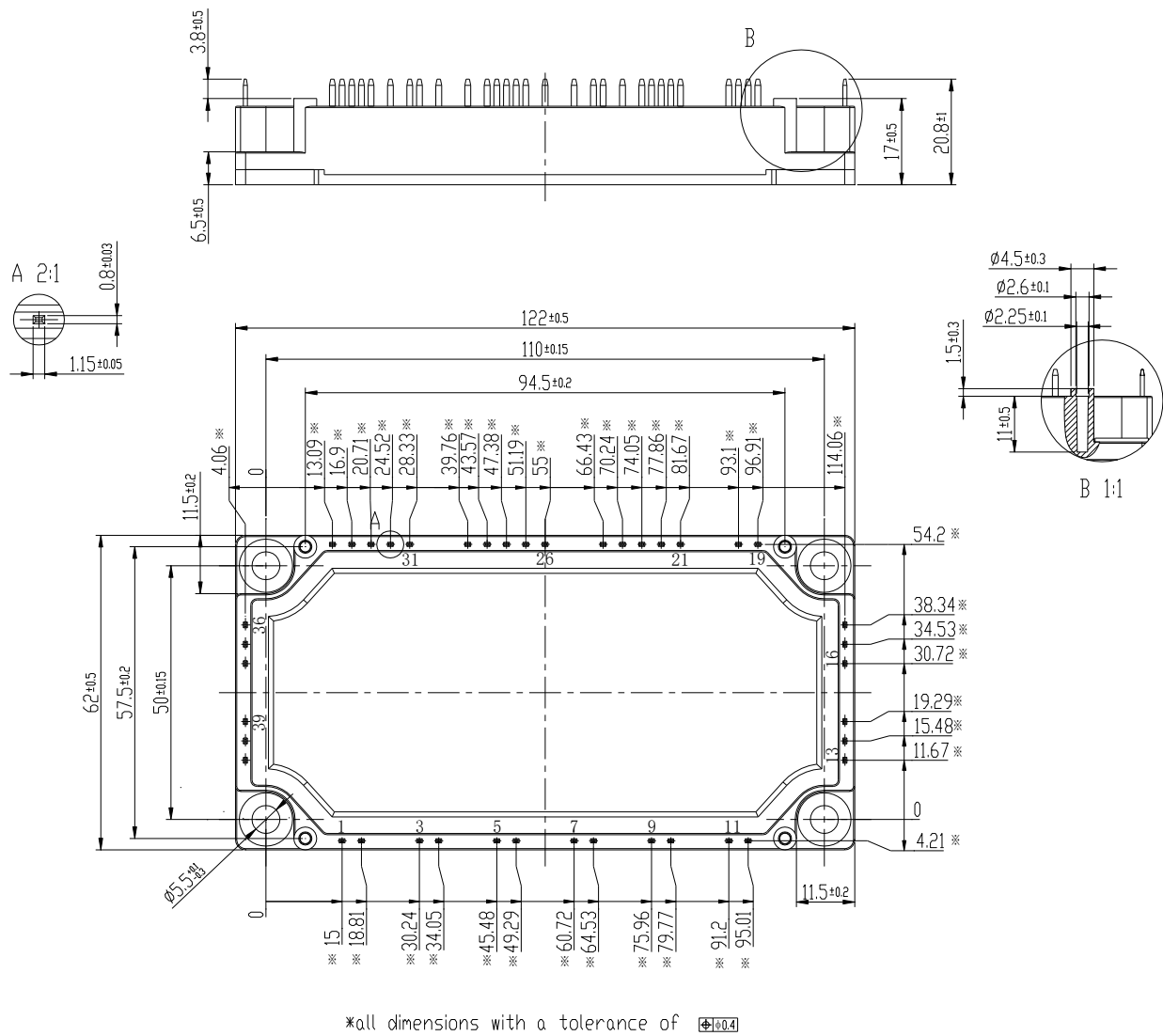


Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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